

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/005,043	YEH ET AL.	
Examiner		Art Unit		Page 1 of 1
Aaron C Perez-Daple		2154		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,131,125 A	10-2000	Rostoker et al.	709/250
	B	US-6,032,203 A	02-2000	Heidhues, Peter Albert	710/11
	C	US-5,729,204	03-1998	Fackler et al.	340/2.4
	D	US-5,875,415 A	02-1999	Lieb et al.	702/122
	E	US-6,334,160 B1	12-2001	Emmert et al.	710/11
	F	US-6,128,673 A	10-2000	Aronson et al.	710/22
	G	US-6,138,180 A	10-2000	Zegelin, Christopher	710/11
	H	US-6,314,479 B1	11-2001	Frederick et al.	710/63
	I	US-5,745,794	04-1998	Poloniewicz et al.	710/62
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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